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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	12675
Number of Logic Elements/Cells	162240
Total RAM Bits	11980800
Number of I/O	400
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	676-BBGA, FCBGA
Supplier Device Package	676-FCBGA (27x27)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7k160t-1fbg676c">https://www.e-xfl.com/product-detail/xilinx/xc7k160t-1fbg676c</a>

Table 1: Absolute Maximum Ratings (1) (Cont'd)

Symbol	Description	Min	Max	Units
I <sub>DCIN</sub>	DC input current for receiver input pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
I <sub>DCOUT</sub>	DC output current for transmitter pins DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	14	mA
<b>XADC</b>				
V <sub>CCADC</sub>	XADC supply relative to GNDADC	–0.5	2.0	V
V <sub>REFP</sub>	XADC reference input relative to GNDADC	–0.5	2.0	V
<b>Temperature</b>				
T <sub>STG</sub>	Storage temperature (ambient)	–65	150	°C
T <sub>SOL</sub>	Maximum soldering temperature for Pb/Sn component bodies (6)	–	+220	°C
	Maximum soldering temperature for Pb-free component bodies (6)	–	+260	°C
T <sub>j</sub>	Maximum junction temperature(6)	–	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).
- The maximum limit applied to DC and AC signals.
- For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
- For soldering guidelines and thermal considerations, see [UG475: 7 Series FPGA Packaging and Pinout Specification](#).

Table 2: Recommended Operating Conditions (1)

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
V <sub>CCINT</sub> <sup>(2)</sup>	Internal supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: internal supply voltage	0.87	0.90	0.93	V
V <sub>CCBRAM</sub> <sup>(2)</sup>	Block RAM supply voltage	0.97	1.00	1.03	V
	For -2L (0.9V) devices: block RAM supply voltage	0.87	0.90	1.03	V
V <sub>CCAUX</sub>	Auxiliary supply voltage	1.71	1.80	1.89	V
V <sub>CCO</sub> <sup>(3)(4)</sup>	Supply voltage for 3.3V HR I/O banks	1.14	–	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	–	1.89	V
V <sub>CCAUX_IO</sub>	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
V <sub>IN</sub> <sup>(5)</sup>	I/O input voltage	–0.20	–	V <sub>CCO</sub> + 0.2	V
	I/O input voltage for V <sub>REF</sub> and differential I/O standards	–0.20	–	2.625	V
I <sub>IN</sub> <sup>(6)</sup>	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	–	–	10	mA
V <sub>CCBATT</sub> <sup>(7)</sup>	Battery voltage	1.0	–	1.89	V
<b>GTX Transceiver</b>					
V <sub>MGTAVCC</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transceiver QPLL frequency range ≤ 10.3125 GHz <sup>(9)(10)</sup>	0.97	1.0	1.08	V
	Analog supply voltage for the GTX transceiver QPLL frequency range > 10.3125 GHz	1.02	1.05	1.08	V
V <sub>MGTAVTT</sub> <sup>(8)</sup>	Analog supply voltage for the GTX transmitter and receiver termination circuits	1.17	1.2	1.23	V
V <sub>MGTVCVAUX</sub> <sup>(8)</sup>	Auxiliary analog QPLL voltage supply for the transceivers	1.75	1.80	1.85	V

**Table 7** shows the minimum current, in addition to  $I_{CCQ}$ , that are required by Kintex-7 devices for proper power-on and configuration. If the current minimums shown in **Table 6** and **Table 7** are met, the device powers on after all five supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the XPower tools to estimate current drain on these supplies.

**Table 7: Power-On Current for Kintex-7 Devices**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCAUX\_IOMIN}$	$I_{CCBRAMMIN}$	Units
	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	
XC7K70T	$I_{CCINTQ} + 450$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K160T	$I_{CCINTQ} + 550$	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K325T	$I_{CCINTQ} + 600$	$I_{CCAUXQ} + 80$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 40$	mA
XC7K355T	$I_{CCINTQ} + 1450$	$I_{CCAUXQ} + 109$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 81$	mA
XC7K410T	$I_{CCINTQ} + 1500$	$I_{CCAUXQ} + 125$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 90$	mA
XC7K420T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 108$	mA
XC7K480T	$I_{CCINTQ} + 2200$	$I_{CCAUXQ} + 180$	$I_{CCOQ} + 40 \text{ mA per bank}$	$I_{CCOAUXIOQ} + 40 \text{ mA per bank}$	$I_{CCBRAMQ} + 108$	mA

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. Use the XPower Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.

**Table 8: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCAUX\_IO}$	Ramp time from GND to 90% of $V_{CCAUX\_IO}$		0.2	50	ms
$T_{CCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625\text{V}$	$T_J = 100^\circ\text{C}^{(1)}$	–	500	ms
		$T_J = 85^\circ\text{C}^{(1)}$	–	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms
$T_{MGTVCCAUX}$	Ramp time from GND to 90% of $V_{MGTVCCAUX}$		0.2	50	ms

**Notes:**

1. Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with a worst case  $V_{CCO}$  of 3.465V.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

Table 9: SelectIO DC Input and Output Levels (1)(2)

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	$V$ , Min	$V$ , Max	$V$ , Min	$V$ , Max	$V$ , Max	$V$ , Min	mA	mA
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_I_12	-0.300	$V_{REF} - 0.080$	$V_{REF} + 0.080$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	6.3	-6.3
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.1	-0.1
LVCMOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVCMOS15, LVDCI_15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVCMOS18, LVDCI_18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVCMOS25	-0.300	0.700	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVCMOS33	-0.300	0.800	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVTTL	-0.300	0.800	2.000	3.450	0.400	2.400	Note 7	Note 7
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
PCI33_3	-0.500	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
SSTL12	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	14.25	-14.25
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.0	-13.0
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.9	-8.9
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.0	-13.0
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.9	-8.9
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8	-8
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.4	-13.4

### Notes:

- Tested according to relevant specifications.
- 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
- Supported drive strengths of 2, 4, 6, or 8 mA in HP I/O banks and 4, 8, or 12 mA in HR I/O banks.
- Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, or 16 mA in HR I/O banks.
- Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, 16, or 24 mA in HR I/O banks.
- Supported drive strengths of 4, 8, 12, or 16 mA
- Supported drive strengths of 4, 8, 12, 16, or 24 mA
- For detailed interface specific DC voltage levels, see [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).

Table 10: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	—	—	—	1.250	—	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> –0.405	V <sub>CCO</sub> –0.300	V <sub>CCO</sub> –0.190	0.400	0.600	0.800

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.
6. LVDS\_25 is specified in Table 12.
7. LVDS is specified in Table 13.

Table 11: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OL</sub> <sup>(3)</sup>		V <sub>OH</sub> <sup>(4)</sup>		I <sub>OL</sub>		I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min	V, Min	mA, Max	mA, Min	
DIFF_HSTL_I	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	8.00	—8.00				
DIFF_HSTL_II	0.300	0.750	1.125	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	—	0.400	V <sub>CCO</sub> –0.400	16.00	—16.00				
DIFF_HSUL_12	0.300	0.600	0.850	0.100	—	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	—0.100				
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	—	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	—0.100				
DIFF_SSTL12	0.300	0.600	0.850	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	14.25	—14.25				
DIFF_SSTL135	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	—13.0				
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	—	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	—8.9				
DIFF_SSTL15	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	—13.0				
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	—	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	—8.9				
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	—8.00				
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	—	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	—13.4				

**Notes:**

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases.

**Table 15** lists the production released Kintex-7 device, speed grade, and the minimum corresponding supported speed specification version and ISE software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 15: Kintex-7 Device Production Software and Speed Specification Release**

Device	Speed Grade Designations			
	1.0V		0.9V	
	-3	-2/-2L	-1	-2L
XC7K70T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K160T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K325T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K355T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K410T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K420T		ISE 14.2 v1.06		ISE 14.3 v1.06
XC7K480T		ISE 14.2 v1.06		ISE 14.3 v1.06

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Kintex-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 11](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

**Table 16: Networking Applications Interface Performances**

Description	I/O Bank Type	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	625	Mb/s	
	HP	710	710	625	625	Mb/s	
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	950	Mb/s	
	HP	1600	1400	1250	1250	Mb/s	

### Notes:

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

Table 17: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FFG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub>	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	2.0V	1866	1866	1600	1333	Mb/s
	HP	1.8V	1600	1333	1066	1066	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1600	1600	1333	1066	Mb/s
	HP	1.8V	1333	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	800	800	800	Mb/s
RLDRAM III <sup>(3)</sup>	HP	2.0V	800	667	667	533	MHz
	HP	1.8V	550	500	450	450	MHz
	HR	N/A			N/A		
<b>2:1 Memory Controllers</b>							
DDR3	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	1066	1066	800	800	Mb/s
DDR3L	HP	2.0V	1066	1066	800	800	Mb/s
	HP	1.8V	1066	1066	800	800	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V					
	HR	N/A					
QDR II+ <sup>(4)</sup>	HP	2.0V	550	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
RLDRAM II	HP	2.0V	533	500	450	450	MHz
	HP	1.8V					
	HR	N/A					
LPDDR2 <sup>(3)</sup>	HP	2.0V	800	800	800	800	Mb/s
	HP	1.8V	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586, 7 Series FPGAs Memory Interface Solutions User Guide](#).
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
4. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

Table 18: Maximum Physical Interface (PHY) Rate for Memory Interfaces (FBG Packages)<sup>(1)(2)</sup>

Memory Standard	I/O Bank Type	V <sub>CCAUX_IO</sub> <sup>(3)</sup>	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
<b>4:1 Memory Controllers</b>							
DDR3	HP	N/A	1333	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
RLDRAM III <sup>(4)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A			N/A		
<b>2:1 Memory Controllers</b>							
DDR3	HP	N/A	1066	1066	800	800	Mb/s
	HR	N/A	1066	800	800	800	Mb/s
DDR3L	HP	N/A	1066	800	667	667	Mb/s
	HR	N/A	800	800	667	667	Mb/s
DDR2	HP	N/A	800	800	800	800	Mb/s
	HR	N/A	800	667	667	667	Mb/s
QDR II+ <sup>(5)</sup>	HP	N/A	550	500	450	450	MHz
	HR	N/A	450	400	350	350	MHz
RLDRAM II	HP	N/A	533	500	450	450	MHz
	HR	N/A					
LPDDR2 <sup>(4)</sup>	HP	N/A	667	667	667	667	Mb/s
	HR	N/A	667	667	533	533	Mb/s

**Notes:**

1. V<sub>REF</sub> tracking is required. For more information, see [UG586, 7 Series FPGAs Memory Interface Solutions User Guide](#).
2. When using the internal V<sub>REF</sub> the maximum data rate is 800 Mb/s (400 MHz).
3. FBG packages do not have separate V<sub>CCAUX\_IO</sub> supply pins to adjust the pre-driver voltage of the HP I/O banks.
4. RLDRAM III (BL = 4, BL = 8) and LPDDR2 specifications have not been validated with memory IP.
5. The maximum QDRII+ performance specifications are for burst-length 4 (BL = 4) implementations. Burst length 2 (BL = 2) implementations are limited to 333 MHz for all speed grades and I/O bank types.

## IOB Pad Input/Output/3-State

**Table 19** (3.3V high-range IOB (HR)) and **Table 20** (1.8V high-performance IOB (HP)) summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

- $T_{IOP}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer. In HP I/O banks, the internal DCI termination turn-on time is always faster than  $T_{IOTP}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the IN\_TERM termination turn-on time is always faster than  $T_{IOTP}$  when the INTERMDISABLE pin is used.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics

I/O Standard	$T_{IOP}$				$T_{IOOP}$				$T_{IOTP}$				Units	
	Speed Grade			Speed Grade			Speed Grade			Speed Grade				
	1.0V		0.9V	1.0V		0.9V	1.0V		0.9V	Speed Grade				
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVTTL_S4	1.31	1.42	1.64	1.51	5.27	5.63	6.05	4.13	6.03	6.49	7.04	4.64	ns	
LVTTL_S8	1.31	1.42	1.64	1.51	4.45	4.83	5.30	3.86	5.21	5.69	6.29	4.38	ns	
LVTTL_S12	1.31	1.42	1.64	1.51	4.45	4.83	5.29	3.84	5.21	5.69	6.28	4.36	ns	
LVTTL_S16	1.31	1.42	1.64	1.51	3.47	3.88	4.40	3.39	4.23	4.74	5.39	3.91	ns	
LVTTL_S24	1.31	1.42	1.64	1.51	3.58	3.99	4.51	3.61	4.34	4.85	5.50	4.13	ns	
LVTTL_F4	1.31	1.42	1.64	1.51	4.70	4.98	5.29	3.58	5.46	5.84	6.28	4.09	ns	
LVTTL_F8	1.31	1.42	1.64	1.51	3.66	4.06	4.56	3.06	4.42	4.92	5.55	3.58	ns	
LVTTL_F12	1.31	1.42	1.64	1.51	3.66	4.06	4.56	3.05	4.42	4.92	5.55	3.56	ns	
LVTTL_F16	1.31	1.42	1.64	1.51	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns	
LVTTL_F24	1.31	1.42	1.64	1.51	2.41	2.64	2.89	2.94	3.17	3.50	3.88	3.45	ns	
LVDS_25 <sup>(1)</sup>	0.64	0.68	0.80	0.83	1.36	1.47	1.55	1.58	2.12	2.33	2.54	2.09	ns	
MINI_LVDS_25	0.68	0.70	0.79	0.83	1.36	1.47	1.55	1.59	2.12	2.33	2.54	2.11	ns	
BLVDS_25 <sup>(1)</sup>	0.65	0.69	0.80	0.83	1.83	2.02	2.20	2.16	2.59	2.88	3.19	2.67	ns	
RSDS_25 (point to point) <sup>(1)</sup>	0.63	0.68	0.79	0.83	1.36	1.48	1.55	1.59	2.12	2.34	2.54	2.11	ns	
PPDS_25 <sup>(1)</sup>	0.65	0.69	0.80	0.83	1.36	1.49	1.58	1.59	2.12	2.35	2.57	2.11	ns	
TMDS_33 <sup>(1)</sup>	0.72	0.76	0.86	0.83	1.43	1.54	1.60	1.70	2.19	2.40	2.59	2.22	ns	
PCI33_3 <sup>(1)</sup>	1.28	1.41	1.65	1.50	2.71	3.08	3.52	3.42	3.47	3.94	4.51	3.94	ns	
HSUL_12	0.63	0.64	0.71	0.79	2.06	2.31	2.59	2.13	2.82	3.17	3.58	2.64	ns	
DIFF_HSUL_12	0.58	0.61	0.70	0.81	1.83	2.04	2.26	1.92	2.59	2.90	3.25	2.44	ns	
HSTL_I_S	0.61	0.64	0.73	0.79	1.55	1.69	1.80	1.91	2.31	2.55	2.79	2.42	ns	
HSTL_II_S	0.61	0.64	0.73	0.78	1.21	1.34	1.43	1.70	1.97	2.20	2.42	2.22	ns	
HSTL_I_18_S	0.64	0.67	0.76	0.79	1.28	1.39	1.45	1.58	2.04	2.25	2.44	2.09	ns	
HSTL_II_18_S	0.64	0.67	0.76	0.79	1.18	1.31	1.40	1.69	1.94	2.17	2.39	2.20	ns	
DIFF_HSTL_I_S	0.63	0.67	0.77	0.78	1.42	1.54	1.61	1.84	2.18	2.40	2.60	2.36	ns	
DIFF_HSTL_II_S	0.63	0.67	0.77	0.79	1.15	1.24	1.27	1.78	1.91	2.10	2.26	2.30	ns	
DIFF_HSTL_I_18_S	0.65	0.69	0.78	0.79	1.27	1.38	1.43	1.67	2.03	2.24	2.42	2.19	ns	
DIFF_HSTL_II_18_S	0.65	0.69	0.78	0.81	1.14	1.23	1.26	1.72	1.90	2.09	2.25	2.23	ns	

Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
HSTL_I_F	0.61	0.64	0.73	0.79	1.10	1.19	1.23	1.41	1.86	2.05	2.22	1.92	ns	
HSTL_II_F	0.61	0.64	0.73	0.78	1.05	1.18	1.28	1.42	1.81	2.04	2.27	1.94	ns	
HSTL_I_18_F	0.64	0.67	0.76	0.79	1.05	1.18	1.28	1.44	1.81	2.04	2.27	1.95	ns	
HSTL_II_18_F	0.64	0.67	0.76	0.79	1.03	1.14	1.23	1.42	1.79	2.00	2.22	1.94	ns	
DIFF_HSTL_I_F	0.63	0.67	0.77	0.78	1.09	1.18	1.22	1.48	1.85	2.04	2.21	2.00	ns	
DIFF_HSTL_II_F	0.63	0.67	0.77	0.79	1.02	1.11	1.14	1.48	1.78	1.97	2.13	2.00	ns	
DIFF_HSTL_I_18_F	0.65	0.69	0.78	0.79	1.08	1.17	1.21	1.48	1.84	2.03	2.20	2.00	ns	
DIFF_HSTL_II_18_F	0.65	0.69	0.78	0.81	1.01	1.10	1.13	1.48	1.77	1.96	2.12	2.00	ns	
LVCMOS33_S4	1.31	1.40	1.60	1.54	5.23	5.61	6.09	4.13	5.99	6.47	7.08	4.64	ns	
LVCMOS33_S8	1.31	1.40	1.60	1.54	4.46	4.85	5.33	3.84	5.22	5.71	6.32	4.36	ns	
LVCMOS33_S12	1.31	1.40	1.60	1.54	3.46	3.89	4.42	3.41	4.22	4.75	5.41	3.92	ns	
LVCMOS33_S16	1.31	1.40	1.60	1.54	3.06	3.43	3.88	3.72	3.82	4.29	4.87	4.23	ns	
LVCMOS33_F4	1.31	1.40	1.60	1.54	4.70	5.01	5.36	3.58	5.46	5.87	6.35	4.09	ns	
LVCMOS33_F8	1.31	1.40	1.60	1.54	3.62	4.04	4.56	3.06	4.38	4.90	5.55	3.58	ns	
LVCMOS33_F12	1.31	1.40	1.60	1.54	2.57	2.85	3.15	2.88	3.33	3.71	4.14	3.39	ns	
LVCMOS33_F16	1.31	1.40	1.60	1.54	2.44	2.69	2.96	2.88	3.20	3.55	3.95	3.39	ns	
LVCMOS25_S4	1.08	1.16	1.32	1.36	4.49	4.80	5.16	3.44	5.25	5.66	6.15	3.95	ns	
LVCMOS25_S8	1.08	1.16	1.32	1.36	3.66	4.04	4.49	3.20	4.42	4.90	5.48	3.72	ns	
LVCMOS25_S12	1.08	1.16	1.32	1.36	2.77	3.10	3.49	2.80	3.53	3.96	4.48	3.31	ns	
LVCMOS25_S16	1.08	1.16	1.32	1.36	3.24	3.62	4.09	3.14	4.00	4.48	5.08	3.66	ns	
LVCMOS25_F4	1.08	1.16	1.32	1.36	3.96	4.31	4.72	3.06	4.72	5.17	5.71	3.58	ns	
LVCMOS25_F8	1.08	1.16	1.32	1.36	2.43	2.87	3.42	2.50	3.19	3.73	4.41	3.02	ns	
LVCMOS25_F12	1.08	1.16	1.32	1.36	2.23	2.63	3.13	2.48	2.99	3.49	4.12	3.00	ns	
LVCMOS25_F16	1.08	1.16	1.32	1.36	1.92	2.17	2.45	2.33	2.68	3.03	3.44	2.84	ns	
LVCMOS18_S4	0.64	0.66	0.74	0.87	3.24	3.45	3.66	1.91	4.00	4.31	4.65	2.42	ns	
LVCMOS18_S8	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S12	0.64	0.66	0.74	0.87	2.58	2.91	3.31	2.50	3.34	3.77	4.30	3.02	ns	
LVCMOS18_S16	0.64	0.66	0.74	0.87	1.82	2.03	2.24	1.84	2.58	2.89	3.23	2.36	ns	
LVCMOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.74	1.92	2.08	1.92	2.50	2.78	3.07	2.44	ns	
LVCMOS18_F4	0.64	0.66	0.74	0.87	3.12	3.31	3.49	1.77	3.88	4.17	4.48	2.28	ns	
LVCMOS18_F8	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F12	0.64	0.66	0.74	0.87	1.91	2.13	2.36	2.00	2.67	2.99	3.35	2.52	ns	
LVCMOS18_F16	0.64	0.66	0.74	0.87	1.52	1.68	1.81	1.72	2.28	2.54	2.80	2.23	ns	
LVCMOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	0.87	1.34	1.46	1.55	1.66	2.10	2.32	2.54	2.17	ns	
LVCMOS15_S4	0.66	0.69	0.81	0.90	3.48	3.74	4.03	2.22	4.24	4.60	5.02	2.73	ns	
LVCMOS15_S8	0.66	0.69	0.81	0.90	2.37	2.67	3.01	2.41	3.13	3.53	4.00	2.92	ns	
LVCMOS15_S12	0.66	0.69	0.81	0.90	1.83	2.03	2.23	1.91	2.59	2.89	3.22	2.42	ns	

## CLB Distributed RAM Switching Characteristics (SLICEM Only)

Table 29: CLB Distributed RAM Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Sequential Delays</b>						
T <sub>SHCKO</sub>	Clock to A – B outputs	0.68	0.70	0.85	1.08	ns, Max
T <sub>SHCKO_1</sub>	Clock to AMUX – BMUX outputs	0.91	0.95	1.15	1.44	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>DS_LRAM</sub> /T <sub>DH_LRAM</sub>	A – D inputs to CLK	0.45/0.23	0.45/0.24	0.54/0.27	0.69/0.33	ns, Min
T <sub>AS_LRAM</sub> /T <sub>AH_LRAM</sub>	Address An inputs to clock	0.13/0.50	0.14/0.50	0.17/0.58	0.21/0.63	ns, Min
	Address An inputs through MUXs and/or carry logic to clock	0.40/0.16	0.42/0.17	0.52/0.23	0.63/0.23	ns, Min
T <sub>WS_LRAM</sub> /T <sub>WH_LRAM</sub>	WE input to clock	0.29/0.09	0.30/0.09	0.36/0.09	0.46/0.10	ns, Min
T <sub>CECK_LRAM</sub> / T <sub>CKCE_LRAM</sub>	CE input to CLK	0.29/0.09	0.30/0.09	0.37/0.09	0.47/0.10	ns, Min
<b>Clock CLK</b>						
T <sub>MPW</sub>	Minimum pulse width	0.68	0.77	0.91	1.11	ns, Min
T <sub>MCP</sub>	Minimum clock period	1.35	1.54	1.82	2.22	ns, Min

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.
2. T<sub>SHCKO</sub> also represents the CLK to XMUX output. Refer to TRACE report for the CLK to XMUX path.

## CLB Shift Register Switching Characteristics (SLICEM Only)

Table 30: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Sequential Delays</b>						
T <sub>REG</sub>	Clock to A – D outputs	0.96	0.98	1.20	1.35	ns, Max
T <sub>REG_MUX</sub>	Clock to AMUX – DMUX output	1.19	1.23	1.50	1.72	ns, Max
T <sub>REG_M31</sub>	Clock to DMUX output via M31 output	0.89	0.91	1.10	1.25	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>WS_SHFREG</sub> / T <sub>WH_SHFREG</sub>	WE input	0.26/0.09	0.27/0.09	0.33/0.09	0.41/0.10	ns, Min
T <sub>CECK_SHFREG</sub> / T <sub>CKCE_SHFREG</sub>	CE input to CLK	0.27/0.09	0.28/0.09	0.33/0.09	0.42/0.10	ns, Min
T <sub>DS_SHFREG</sub> / T <sub>DH_SHFREG</sub>	A – D inputs to CLK	0.28/0.26	0.28/0.26	0.33/0.30	0.41/0.36	ns, Min
<b>Clock CLK</b>						
T <sub>MPW_SHFREG</sub>	Minimum pulse width	0.55	0.65	0.78	0.91	ns, Min

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

## Block RAM and FIFO Switching Characteristics

Table 31: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Block RAM and FIFO Clock-to-Out Delays</b>						
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.57	1.80	2.08	2.44	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.54	0.63	0.75	0.86	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.35	2.58	3.26	4.49	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.62	0.69	0.80	0.94	ns, Max
T <sub>RCKO_DO_CASCOUP</sub> and T <sub>RCKO_DO_CASCOUP_REG</sub>	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.21	2.45	2.80	3.19	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.98	1.08	1.24	1.32	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.65	0.74	0.89	0.97	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.79	0.87	0.98	1.10	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.66	0.72	0.80	0.93	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.17	2.38	3.01	4.15	ns, Max
	Clock CLK to BITERR (with output register)	0.57	0.65	0.76	0.89	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.64	0.74	0.90	0.98	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.71	0.79	0.92	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.38/0.27	0.42/0.28	0.48/0.31	0.65/0.38	ns, Min
T <sub>RDCK_DI_WF_NC</sub> /T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.49/0.51	0.55/0.53	0.63/0.57	0.78/0.64	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.17/0.25	0.19/0.29	0.21/0.35	0.25/0.32	ns, Min
T <sub>RDCK_DI_ECC</sub> /T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.42/0.37	0.47/0.39	0.53/0.43	0.66/0.46	ns, Min
T <sub>RDCK_DI_ECCW</sub> /T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.79/0.37	0.87/0.39	0.99/0.43	1.17/0.41	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> /T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	0.89/0.47	0.98/0.50	1.12/0.54	1.32/0.65	ns, Min
T <sub>RCKC_INJECTBITERR</sub> /T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.49/0.30	0.55/0.31	0.63/0.34	0.78/0.41	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.30/0.17	0.33/0.18	0.38/0.20	0.48/0.22	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.21/0.13	0.25/0.13	0.31/0.14	0.34/0.16	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.25/0.06	0.27/0.06	0.29/0.06	0.35/0.06	ns, Min

Table 32: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_MREG</sub>	CLK MREG to P output	1.42	1.64	1.96	2.31	ns
T <sub>DSPCKO_CARRYCASCOU_MREG</sub>	CLK MREG to CARRYCASCOU output	1.63	1.87	2.24	2.65	ns
T <sub>DSPCKO_P_ADREG_MULT</sub>	CLK ADREG to P output using multiplier	2.30	2.63	3.13	3.90	ns
T <sub>DSPCKO_CARRYCASCOU_ADREG_MULT</sub>	CLK ADREG to CARRYCASCOU output using multiplier	2.51	2.87	3.41	4.23	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_AREG_MULT</sub>	CLK AREG to P output using multiplier	3.34	3.83	4.55	5.80	ns
T <sub>DSPCKO_P_BREG</sub>	CLK BREG to P output not using multiplier	1.39	1.59	1.88	2.24	ns
T <sub>DSPCKO_P_CREG</sub>	CLK CREG to P output not using multiplier	1.43	1.64	1.95	2.32	ns
T <sub>DSPCKO_P_DREG_MULT</sub>	CLK DREG to P output using multiplier	3.32	3.80	4.51	5.74	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
T <sub>DSPCKO_{ACOUT; BCOUT}_{AREG; BREG}</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.55	0.62	0.74	0.87	ns
T <sub>DSPCKO_CARRYCASCOU_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	3.55	4.06	4.84	6.13	ns
T <sub>DSPCKO_CARRYCASCOU_BREG</sub>	CLK BREG to CARRYCASCOU output not using multiplier	1.60	1.82	2.16	2.58	ns
T <sub>DSPCKO_CARRYCASCOU_DREG_MULT</sub>	CLK DREG to CARRYCASCOU output using multiplier	3.52	4.03	4.79	6.07	ns
T <sub>DSPCKO_CARRYCASCOU_CREG</sub>	CLK CREG to CARRYCASCOU output	1.64	1.88	2.23	2.65	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	With all registers used	741.84	650.20	547.95	429.37	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	627.35	549.75	463.61	365.90	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	412.20	360.75	303.77	248.32	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	374.25	327.65	276.01	225.73	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	468.82	408.66	342.70	263.44	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	468.82	408.66	342.70	263.44	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	306.84	267.81	225.02	177.15	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	285.23	249.13	209.38	165.32	MHz

## MMCM Switching Characteristics

Table 38: MMCM Specification

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
MMCM_F <sub>INMAX</sub>	Maximum Input Clock Frequency	1066.00	933.00	800.00	800.00	MHz
MMCM_F <sub>INMIN</sub>	Minimum Input Clock Frequency	10.00	10.00	10.00	10.00	MHz
MMCM_F <sub>INJITTER</sub>	Maximum Input Clock Period Jitter	< 20% of clock input period or 1 ns Max				
MMCM_F <sub>INDUTY</sub>	Allowable Input Duty Cycle: 10—49 MHz	25.00	25.00	25.00	25.00	%
	Allowable Input Duty Cycle: 50—199 MHz	30.00	30.00	30.00	30.00	%
	Allowable Input Duty Cycle: 200—399 MHz	35.00	35.00	35.00	35.00	%
	Allowable Input Duty Cycle: 400—499 MHz	40.00	40.00	40.00	40.00	%
	Allowable Input Duty Cycle: >500 MHz	45.00	45.00	45.00	45.00	%
MMCM_F <sub>MIN_PSCLK</sub>	Minimum Dynamic Phase Shift Clock Frequency	0.01	0.01	0.01	0.01	MHz
MMCM_F <sub>MAX_PSCLK</sub>	Maximum Dynamic Phase Shift Clock Frequency	550.00	500.00	450.00	450.00	MHz
MMCM_F <sub>VCOMIN</sub>	Minimum MMCM VCO Frequency	600.00	600.00	600.00	600.00	MHz
MMCM_F <sub>VCOMAX</sub>	Maximum MMCM VCO Frequency	1600.00	1440.00	1200.00	1200.00	MHz
MMCM_F <sub>BANDWIDTH</sub>	Low MMCM Bandwidth at Typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High MMCM Bandwidth at Typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
MMCM_T <sub>STATPHAOFFSET</sub>	Static Phase Offset of the MMCM Outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
MMCM_T <sub>OUTJITTER</sub>	MMCM Output Jitter	Note 3				
MMCM_T <sub>OUTDUTY</sub>	MMCM Output Clock Duty Cycle Precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
MMCM_T <sub>LOCKMAX</sub>	MMCM Maximum Lock Time	100.00	100.00	100.00	100.00	μs
MMCM_F <sub>OUTMAX</sub>	MMCM Maximum Output Frequency	1066.00	933.00	800.00	800.00	MHz
MMCM_F <sub>OUTMIN</sub>	MMCM Minimum Output Frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	4.69	MHz
MMCM_T <sub>EXTFDVAR</sub>	External Clock Feedback Variation	< 20% of clock input period or 1 ns Max				
MMCM_RST <sub>MINPULSE</sub>	Minimum Reset Pulse Width	5.00	5.00	5.00	5.00	ns
MMCM_F <sub>PFDMAX</sub>	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to High or Optimized	550.00	500.00	450.00	450.00	MHz
	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to Low	300.00	300.00	300.00	300.00	MHz
MMCM_F <sub>PFDMIN</sub>	Minimum Frequency at the Phase Frequency Detector	10.00	10.00	10.00	10.00	MHz
MMCM_T <sub>FBDELAY</sub>	Maximum Delay in the Feedback Path	3 ns Max or one CLKIN cycle				
<b>MMCM Switching Characteristics Setup and Hold</b>						
T <sub>MMCMDCK_PSEN</sub> /T <sub>MMCMCKD_PSEN</sub>	Setup and Hold of Phase Shift Enable	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMDCK_PSINCDEC</sub> /T <sub>MMCMCKD_PSINCDEC</sub>	Setup and Hold of Phase Shift Increment/Decrement	1.04/0.00	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMCKO_PSDONE</sub>	Phase Shift Clock-to-Out of PSDONE	0.59	0.68	0.81	0.78	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>						
T <sub>MMCMDCK_DADDR</sub> /T <sub>MMCMCKD_DADDR</sub>	DADDR Setup/Hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>MMCMDCK_DI</sub> /T <sub>MMCMCKD_DI</sub>	DI Setup/Hold	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min

**Table 42: Clock-Capable Clock Input to Output Delay With MMCM**

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with MMCM</i> .							
TICKOFMMCMCC	Clock-capable clock input and OUTFF <i>with MMCM</i>	XC7K70T	0.95	0.95	0.95	1.74	ns
		XC7K160T	0.96	0.96	0.96	1.78	ns
		XC7K325T	1.00	1.00	1.00	1.82	ns
		XC7K355T	1.00	1.00	1.00	1.78	ns
		XC7K410T	1.00	1.00	1.00	1.82	ns
		XC7K420T	1.07	1.07	1.07	1.82	ns
		XC7K480T	1.07	1.07	1.07	1.82	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. MMCM output jitter is already included in the timing calculation.

**Table 43: Clock-Capable Clock Input to Output Delay With PLL**

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with PLL</i> .							
TICKOFPLLCC	Clock-capable clock input and OUTFF <i>with PLL</i>	XC7K70T	0.84	0.84	0.84	1.45	ns
		XC7K160T	0.89	0.89	0.89	1.54	ns
		XC7K325T	0.89	0.89	0.89	1.54	ns
		XC7K355T	0.89	0.89	0.89	1.50	ns
		XC7K410T	0.89	0.89	0.89	1.54	ns
		XC7K420T	0.96	0.96	0.96	1.54	ns
		XC7K480T	0.96	0.96	0.96	1.54	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. PLL output jitter is already included in the timing calculation.

**Table 44: Pin-to-Pin, Clock-to-Out using BUFI0**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>with BUFI0</i> .						
TICKOFC0	Clock-to-Out of I/O clock for HR I/O banks	4.93	5.52	6.20	6.97	ns
	Clock-to-Out of I/O clock for HP I/O banks	4.85	5.44	6.11	6.90	ns

## Device Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

**Table 45: Global Clock Input Setup and Hold Without MMCM/PLL with ZHOLD\_DELAY on HR I/O Banks**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSFD}/T_{PHFD}$	Full Delay (Legacy Delay or Default Delay) Global Clock Input and IFF <sup>(2)</sup> without MMCM/PLL with ZHOLD_DELAY on HR I/O Banks	XC7K70T	2.83/-0.29	2.95/-0.29	3.15/-0.29	4.96/-0.33	ns	
		XC7K160T	3.17/-0.35	3.29/-0.35	3.55/-0.35	5.54/-0.49	ns	
		XC7K325T	2.83/-0.06	2.94/-0.06	3.15/-0.06	5.18/-0.14	ns	
		XC7K355T	3.26/-0.32	3.41/-0.32	3.67/-0.32	5.84/-0.49	ns	
		XC7K410T	3.43/-0.34	3.59/-0.34	3.88/-0.34	6.21/-0.54	ns	
		XC7K420T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	
		XC7K480T	3.37/-0.27	3.48/-0.27	3.76/-0.27	6.00/-0.52	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time.

**Table 46: Clock-Capable Clock Input Setup and Hold With MMCM**

Symbol	Description	Device	Speed Grade				Units	
			1.0V		0.9V			
			-3	-2/-2L	-1	-2L		
Input Setup and Hold Time Relative to Global Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>								
$T_{PSMMCMCC}/T_{PHMMCMCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with MMCM	XC7K70T	2.39/-0.22	2.65/-0.22	2.94/-0.22	2.21/-0.44	ns	
		XC7K160T	2.49/-0.20	2.77/-0.20	3.07/-0.20	2.38/-0.47	ns	
		XC7K325T	2.55/-0.16	2.85/-0.16	3.14/-0.16	2.60/-0.47	ns	
		XC7K355T	2.43/-0.16	2.73/-0.16	3.00/-0.16	2.47/-0.43	ns	
		XC7K410T	2.55/-0.16	2.84/-0.16	3.14/-0.16	2.58/-0.47	ns	
		XC7K420T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	
		XC7K480T	2.47/-0.09	2.73/-0.09	3.02/-0.09	2.40/-0.41	ns	

### Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 47: Clock-Capable Clock Input Setup and Hold With PLL

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to Clock-Capable Clock Input Signal for SSTL15 Standard. <sup>(1)</sup>							
$T_{PSPLLCC}/T_{PHPLLCC}$	No Delay clock-capable clock input and IFF <sup>(2)</sup> with PLL	XC7K70T	2.75/-0.32	3.04/-0.32	3.33/-0.32	2.42/-0.54	ns
		XC7K160T	2.85/-0.31	3.16/-0.31	3.46/-0.31	2.59/-0.56	ns
		XC7K325T	2.91/-0.27	3.24/-0.27	3.54/-0.27	2.80/-0.56	ns
		XC7K355T	2.79/-0.27	3.12/-0.27	3.40/-0.27	2.67/-0.52	ns
		XC7K410T	2.91/-0.27	3.24/-0.27	3.53/-0.27	2.78/-0.56	ns
		XC7K420T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns
		XC7K480T	2.83/-0.20	3.12/-0.20	3.41/-0.20	2.61/-0.50	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 48: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIN

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIN for SSTL15 Standard.						
$T_{PSCS}/T_{PHCS}$	Setup/Hold of I/O clock for HR I/O banks	-0.36/1.36	-0.36/1.50	-0.36/1.70	-0.44/1.87	ns
	Setup/Hold of I/O clock for HP I/O banks	-0.34/1.39	-0.34/1.53	-0.34/1.73	-0.44/1.87	ns

Table 49: Sample Window

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
$T_{SAMP}$	Sampling Error at Receiver Pins <sup>(1)</sup>	0.51	0.56	0.61	0.56	ns
$T_{SAMP\_BUFIN}$	Sampling Error at Receiver Pins using BUFIN <sup>(2)</sup>	0.30	0.35	0.40	0.35	ns

**Notes:**

1. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Kintex-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIN clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

## GTX Transceiver Specifications

### GTX Transceiver DC Input and Output Levels

Table 51 summarizes the DC output specifications of the GTX transceivers in Kintex-7 FPGAs. Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further details.

Table 51: GTX Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	–	–	1000	mV
V <sub>CMOUTDC</sub>	DC common mode output voltage.	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/4$		mV	
R <sub>OUT</sub>	Differential output resistance		–	100	–	Ω
T <sub>OSKEW</sub>	Transmitter output pair (TXP and TXN) intra-pair skew		–	2	12	ps
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage (external AC coupled)	>10.3125 Gb/s	150	–	1250	mV
		6.6 Gb/s to 10.3125 Gb/s	150	–	1250	mV
		≤ 6.6 Gb/s	150	–	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled $V_{MGTAVTT} = 1.2V$	-200	–	$V_{MGTAVTT}$	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled $V_{MGTAVTT} = 1.2V$	–	2/3 $V_{MGTAVTT}$	–	mV
R <sub>IN</sub>	Differential input resistance		–	100	–	Ω
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>		–	100	–	nF

**Notes:**

- The output swing and preemphasis levels are programmable using the attributes discussed in [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) and can result in values lower than reported in this table.
- Other values can be used as appropriate to conform to specific protocols and standards.

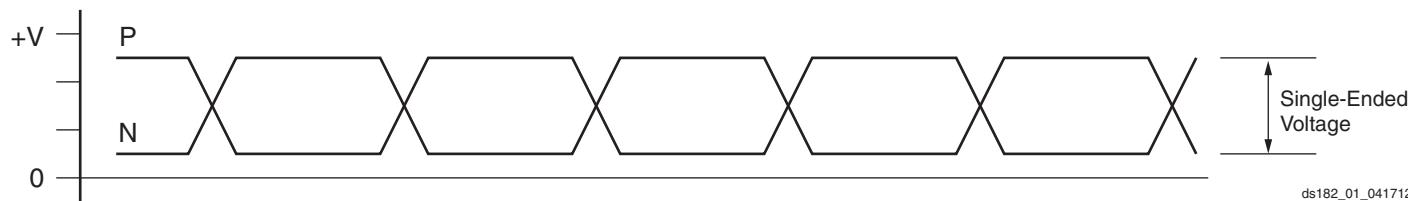


Figure 1: Single-Ended Peak-to-Peak Voltage

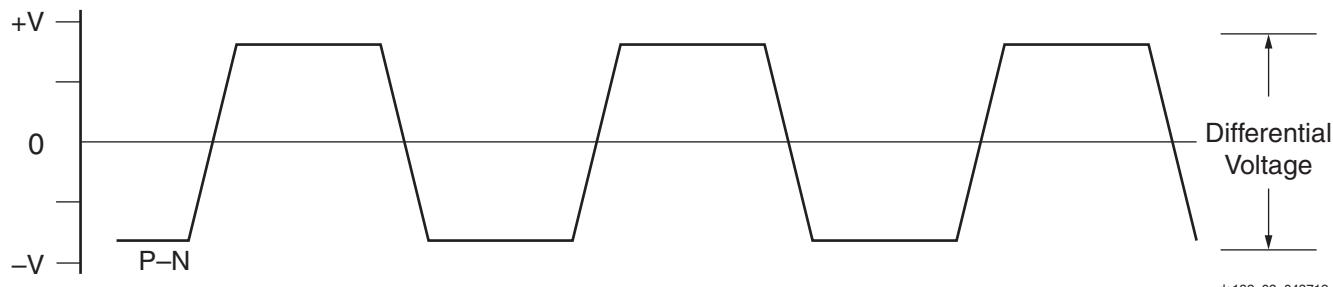


Figure 2: Differential Peak-to-Peak Voltage

**Table 52** summarizes the DC specifications of the clock input of the GTX transceiver. Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further details.

**Table 52: GTX Transceiver Clock DC Input Level Specification**

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	250	—	2000	mV
R <sub>IN</sub>	Differential input resistance	—	100	—	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	—	100	—	nF

## GTX Transceiver Switching Characteristics

Consult [UG476: 7 Series FPGAs GTX/GTH Transceiver User Guide](#) for further information.

**Table 53: GTX Transceiver Performance**

Symbol	Description	Output Divider	Speed Grade								Units	
			1.0V				0.9V					
			-3		-2/-2L		-1 <sup>(1)</sup>		-2L <sup>(2)</sup>			
			Package Type									
			FF	FB	FF	FB	FF	FB	FF	FB		
F <sub>GTXMAX</sub> <sup>(3)</sup>	Maximum GTX transceiver data rate		12.5	6.6	10.3125	6.6	8.0	6.6	6.6	6.6	Gb/s	
F <sub>GTXMIN</sub> <sup>(3)</sup>	Minimum GTX transceiver data rate		0.500	0.500	0.500	0.500	0.500	0.500	0.500	0.500	Gb/s	
F <sub>GTXCRANGE</sub>	CPLL line rate range	1	3.2–6.6								Gb/s	
		2	1.6–3.3								Gb/s	
		4	0.8–1.65								Gb/s	
		8	0.5–0.825								Gb/s	
		16	N/A								Gb/s	
F <sub>GTXQRANGE1</sub>	QPLL line rate range 1	1	5.93–8.0	5.93–6.6	5.93–8.0	5.93–6.6	5.93–8.0	5.93–6.6	5.93–6.6		Gb/s	
		2	2.965–4.0		2.965–4.0		2.965–4.0		2.965–3.3		Gb/s	
		4	1.4825–2.0		1.4825–2.0		1.4825–2.0		1.4825–1.65		Gb/s	
		8	0.74125–1.0		0.74125–1.0		0.74125–1.0		0.74125–0.825		Gb/s	
		16	N/A		N/A		N/A		N/A		Gb/s	
F <sub>GTXQRANGE2</sub>	QPLL line rate range 2 <sup>(4)</sup>	1	9.8–12.5	N/A	9.8–10.3125	N/A	N/A		N/A		Gb/s	
		2	4.9–6.25		4.9–5.15625		N/A		N/A		Gb/s	
		4	2.45–3.125		2.45–2.578125		N/A		N/A		Gb/s	
		8	1.225–1.5625		1.225–1.2890625		N/A		N/A		Gb/s	
		16	0.6125–0.78125		0.6125–0.64453125		N/A		N/A		Gb/s	
F <sub>GCPLLRANGE</sub>	GTX transceiver CPLL frequency range		1.6–3.3		1.6–3.3		1.6–3.3		1.6–3.3		GHz	
F <sub>GQPLLRANGE1</sub>	GTX transceiver QPLL frequency range 1		5.93–8.0		5.93–8.0		5.93–8.0		5.93–6.6		GHz	

## XADC Specifications

Table 67: XADC Specifications

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
$V_{CCADC} = 1.8V \pm 5\%$ , $V_{REFP} = 1.25V$ , $V_{REFN} = 0V$ , $ADCCLK = 26\text{ MHz}$ , $T_j = -40^\circ C$ to $100^\circ C$ , Typical values at $T_j=+40^\circ C$						
<b>ADC Accuracy<sup>(1)</sup></b>						
Resolution			12	–	–	Bits
Integral Nonlinearity <sup>(2)</sup>	INL		–	–	$\pm 3$	LSBs
Differential Nonlinearity	DNL	No missing codes, guaranteed monotonic	–	–	$\pm 1$	LSBs
Offset Error		Offset calibration enabled	–	–	$\pm 6$	LSBs
Gain Error		Gain calibration disabled	–	–	$\pm 0.5$	%
Offset Matching		Offset calibration enabled	–	–	4	LSBs
Gain Matching		Gain calibration disabled	–	–	0.3	%
Sample Rate			0.1	–	1	MS/s
Signal to Noise Ratio <sup>(2)</sup>	SNR	$F_{SAMPLE} = 500\text{KS/s}$ , $F_{IN} = 20\text{KHz}$	60	–	–	dB
RMS Code Noise		External 1.25V reference	–	–	2	LSBs
		On-chip reference	–	3	–	LSBs
Total Harmonic Distortion <sup>(2)</sup>	THD	$F_{SAMPLE} = 500\text{KS/s}$ , $F_{IN} = 20\text{KHz}$	–	70	–	dB
<b>ADC Accuracy at Extended Temperatures (-55°C to 125°C)</b>						
Resolution			10	–	–	Bits
Integral Nonlinearity <sup>(2)</sup>	INL		–	–	$\pm 1$	LSB (at 10 bits)
Differential Nonlinearity	DNL	No missing codes, guaranteed monotonic	–	–	$\pm 1$	
<b>Analog Inputs<sup>(3)</sup></b>						
ADC Input Ranges		Unipolar operation	0	–	1	V
		Bipolar operation	-0.5	–	+0.5	V
		Unipolar common mode range (FS input)	0	–	+0.5	V
		Bipolar common mode range (FS input)	+0.5	–	+0.6	V
Maximum External Channel Input Ranges		Adjacent channels set within these ranges should not corrupt measurements on adjacent channels	-0.1	–	$V_{CCADC}$	V
Auxiliary Channel Full Resolution Bandwidth	FRBW		250	–	–	KHz
<b>On-Chip Sensors</b>						
Temperature Sensor Error		$T_j = -40^\circ C$ to $100^\circ C$ .	–	–	$\pm 4$	°C
		$T_j = -55^\circ C$ to $+125^\circ C$	–	–	$\pm 6$	°C
Supply Sensor Error		Measurement range of $V_{CCAUX}$ 1.8V $\pm 5\%$ $T_j = -40^\circ C$ to $+100^\circ C$	–	–	$\pm 1$	%
		Measurement range of $V_{CCAUX}$ 1.8V $\pm 5\%$ $T_j = -55^\circ C$ to $+125^\circ C$	–	–	$\pm 2$	%
<b>Conversion Rate<sup>(4)</sup></b>						
Conversion Time - Continuous	$t_{CONV}$	Number of ADCCLK cycles	26	–	32	Cycles
Conversion Time - Event	$t_{CONV}$	Number of CLK cycles	–	–	21	Cycles
DRP Clock Frequency	DCLK	DRP clock frequency	8	–	250	MHz
ADC Clock Frequency	ADCCLK	Derived from DCLK	1	–	26	MHz
DCLK Duty Cycle			40	–	60	%

Date	Version	Description
07/25/12	1.6	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed Note 7, changed GTX transceiver parameters and values and added <a href="#">Note 9</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>.</p> <p>Changed the typical values for many of the devices in <a href="#">Table 7</a>. Updated LVCMOS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated speed specification to v1.06 (-3, -2, -2L(1.0V), -1) and v1.05 (-2L(0.9V)) with appropriate changes to <a href="#">Table 14</a> and <a href="#">Table 15</a> including production release of the XC7K325T and the XC7K410T in the -2, -2L(1.0V), and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 17</a> and <a href="#">Table 18</a>.</p> <p>Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 51</a> and <a href="#">Note 8</a>.</p> <p>Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>.</p> <p>In <a href="#">Table 67</a> updated <a href="#">Note 1</a> and added Note 4. In <a href="#">Table 68</a>, updated <math>T_{POR}</math> and <math>F_{EMCCK}</math>.</p>
09/04/12	1.7	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K160T in the -2, -2L(1.0V), and -1 speed designations.
09/26/12	1.8	In <a href="#">Table 2</a> , revised $V_{CCINT}$ and $V_{CCBRAM}$ and added <a href="#">Note 2</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K480T in the -2, -2L(1.0V), and -1 speed designations and the XC7K325T and XC7K410T in the -3 speed designation.
10/10/12	1.9	Updated the $I_{CCINTMIN}$ value for the XC7K355T in <a href="#">Table 7</a> . Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K420T in the -2, -2L(1.0V), and -1 speed designations.
10/25/12	2.0	<p>Updated the <a href="#">AC Switching Characteristics</a> based upon ISE 14.3 v1.07 for the -3, -2, -2L (1.0V), -1 speed specifications, and ISE 14.3 v1.06 for the -2L (0.9V) speed specifications throughout the document.</p> <p>Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K355T in the -2, -2L(1.0V), and -1 speed designations. Also updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K325T and XC7K410T in the -2L (0.9V).</p> <p>Added values for <a href="#">Table 16</a> -2L (0.9V). Added package skew values to <a href="#">Table 50</a>. In <a href="#">Table 53</a>, increased -1 speed grade (FF package) <math>F_{GTXMAX}</math> value from 6.6 Gb/s to 8.0 Gb/s.</p>
10/31/12	2.1	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the XC7K70T in the -2, -2L(1.0V), and -1 speed designations.
11/26/12	2.2	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of -3 speed designation for XC7K70T, XC7K160T, XC7K355T, XC7K420T, and XC7K480T. Removed Note 4 from <a href="#">Table 67</a> .
12/05/12	2.3	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K160T, XC7K420T, and XC7K480T. Updated <a href="#">Note 1</a> in <a href="#">Table 50</a> .
12/12/12	2.4	Updated <a href="#">Table 14</a> and <a href="#">Table 15</a> for production release of the -2L (0.9V) speed designation for XC7K70T and XC7K355T. Added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 68</a> .